

UNIVERSITÉ DE GENÈVE

FACULTÉ DES SCIENCES Département de physique nucléaire et corpusculaire





European Research Council Established by the European Commission

NONDLITHÍN - Picosecond Time Stamping in Fully Monolithic Highlygranular Pixel Sensor

Matteo Milanesio on behalf of the MONOLITH team

University of Geneva

<u> Joint Annual Meeting of SPS and ÖPG, 4 - 8 September 2023 in Basel</u>



The MONOLITH ERC Project



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Monolithic silicon sensor able to:

- measure precisely the 3D spatial position of charged particles
- provide picosecond time resolution

Funded by the H2020 ERC Advanced grant 884447^[1], July 2020 - June 2025

^[1]MONOLITH H2020 ERC Advanced Project Web Page https://www.unige.ch/dpnc/en/groups/giuseppe-iac obucci/research/monolith-erc-advanced-project/

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Fast and low-noise SiGe BiCMOS electronics SiGe BiCMOS SiGe BiCMOS Novel sensor concept, the Picosecond Avalanche Detector®



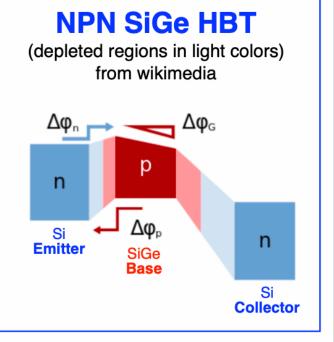
SiGe BiCMOS Technology



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- SiGe HBT = BJT with Germanium as base material:
 - higher doping in base possible
 - thinner base
 - reduced base resistance R_b
- Grading of Ge doping in base:
 - charge transport in base via drift
 - reduced charge transit time in base
 - high current gain β



$$ENC_{series\ noise} \propto \sqrt{k_1 \frac{C_{tot}^2}{\beta} + k_2 R_b C_{tot}^2} \implies \sigma_{jitter} = \frac{\sigma_V}{\frac{dV}{dt}} \approx ENC * Rise\ Time$$



Leading-edge IHP SG13G2 technology: 130 nm process featuring SiGe HBT





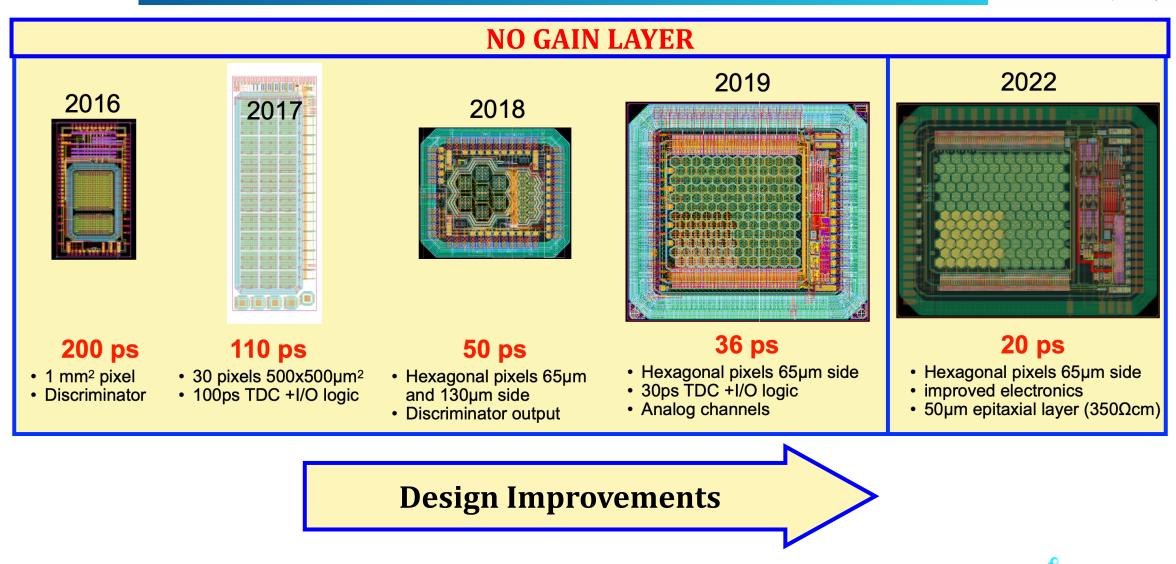
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Monolithic SiGe BiCMOS prototypes



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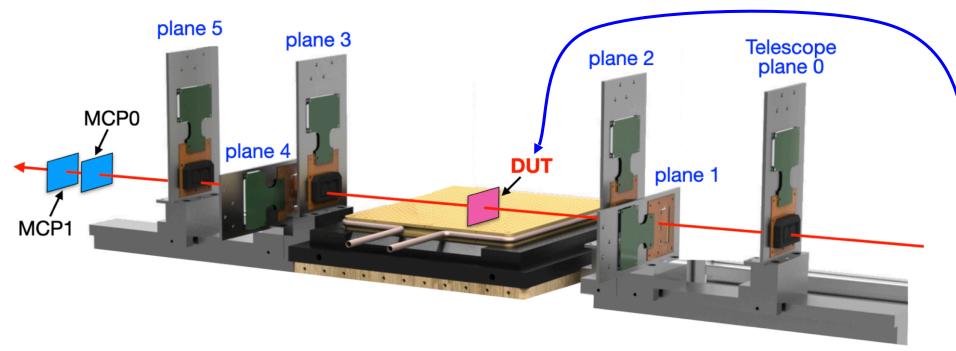


Test Beam: Experimental Setup



NO GAIN LAYER

- October 2022: SPS Testbeam with 180 GeV/c pions
- Measure **efficiency** and **time resolution**



- UNIGE FE-I4 telescope^[2] to provide the spatial information ($\sigma_{x,y} \sim 10 \ \mu m$)
- Two MCPs ($\sigma_t \sim 5 \text{ ps}$) to provide the timing reference

06/09/23

2022

50µm epitaxial layer (350Ωcm)

^[2]Benoit et al. The FE-I4 telescope for particle tracking in testbeam experiments. JINST, 11 P07003, july 2016

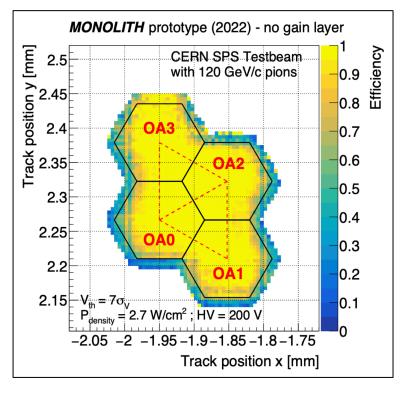




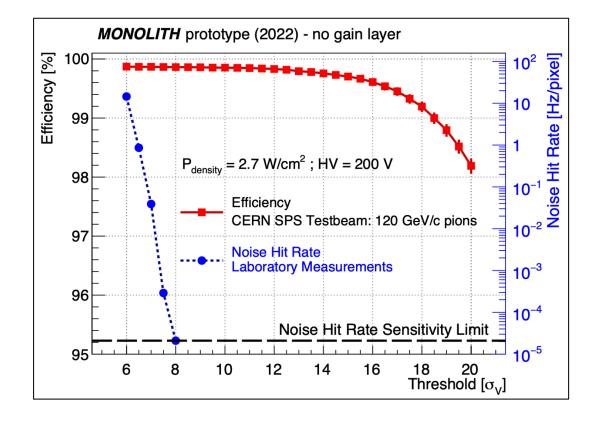
Efficiency Results



6



- The apparent degradation at the edges is due to the ${\sim}10~\mu m$ resolution of the telescope
- Selection of two **triangles**:
 - representative of the whole pixel
 - **unbiased** from the telescope resolution



- Large plateau of **99.8% efficiency**
- $\sigma_V \approx 1.4 \text{ mV} \approx 100 e^-$



06/09/23



Time Resolution Results



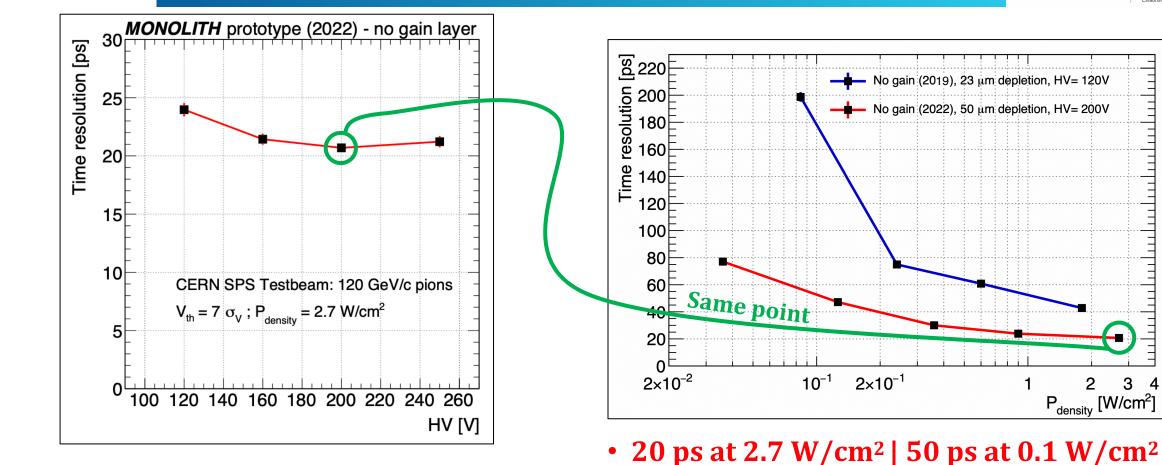
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P_{density} [W/cm²]

3 4

7

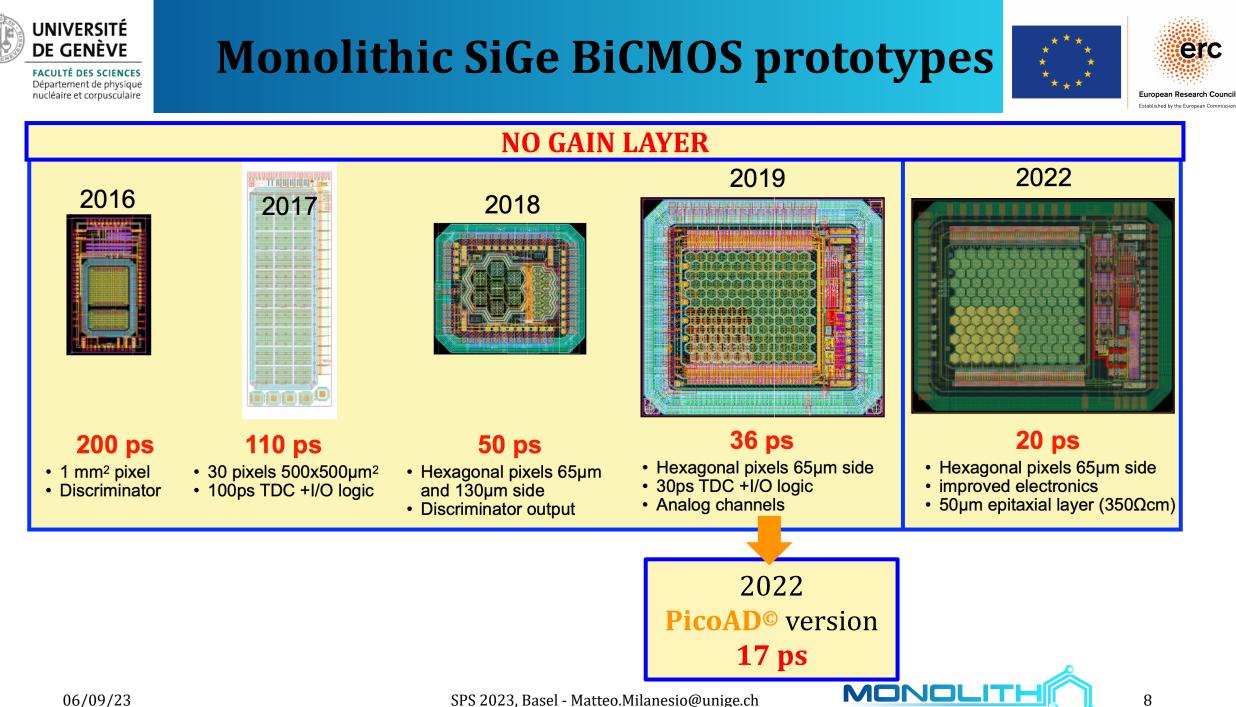
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Large plateau of 130 V between 20 and 25 ps

• More than a factor 2 improvement w.r.t. the previous prototype







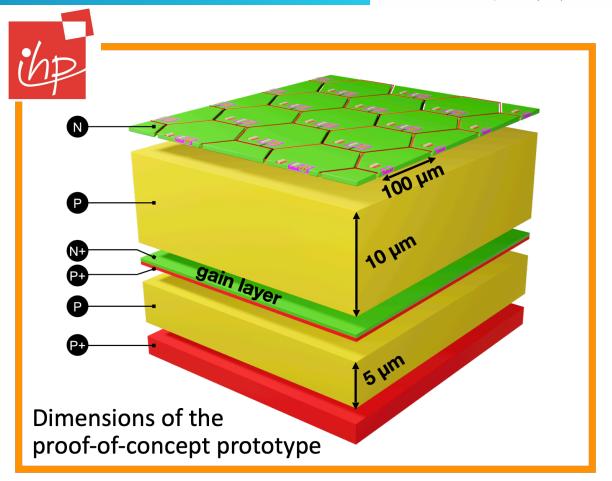
PicoAD[©] **Prototype**



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- Multi-Junction Pico-Avalanche Detector^[4]
- 2019 ASIC with the PicoAD[©] concept
- Continuous and deep gain layer
 - de-correlation from implant size/geometry -> high **pixel granularity** possible (enhance spatial resolution)
 - only small fraction of charge gets amplified -> reduced charge collection noise (enhance timing resolution)



^[4]G. Iacobucci, L. Paolozzi and P. Valerio. Multi-junction pico-avalanche detector. European Patent EP3654376A1, US Patent US2021280734A1. Nov 2018





Gain Measurements



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• X-rays from ⁵⁵Fe radioactive source^{[5][6]}:

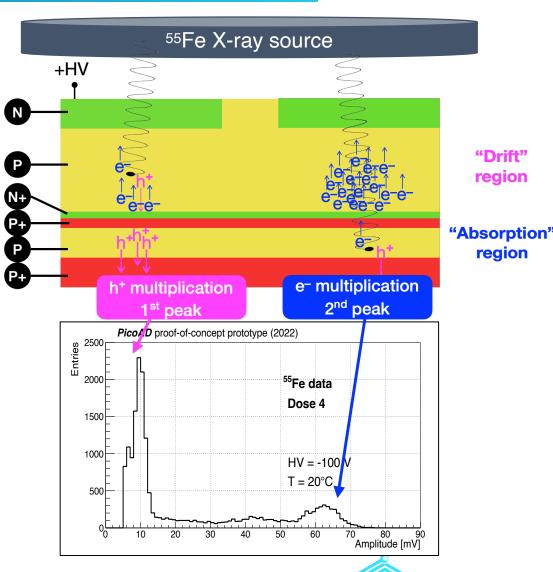
- mainly ~5.9 keV photons
- point-like charge deposition

Characteristic double-peak spectrum

- photon absorbed in **drift region**
 - holes drift through gain layer and multiplied
 - first peak in the spectrum
- photon absorbed in absorption region
 - electrons drift through gain layer and multiplied
 - **second peak** in the spectrum

• Gain up to ≈ 20 for ⁵⁵Fe X-rays obtained with HV = -125 V and T = -20 °C

[5]M. Milanesio et al, Gain measurements of the first proof-of-concept PicoAD prototype with a ⁵⁵Fe X-ray radioactive source, 2022 doi.org/10.1016/j.nima.2022.167807 [6]L. Paolozzi et al, Picosecond Avalanche Detector - working principle and gain measurement with a proof-of-concept prototype, 2022 JINST 17 P10032



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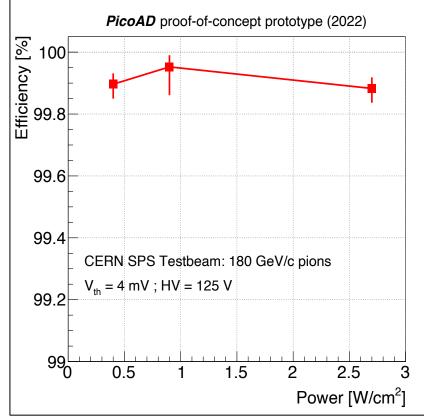


Efficiency and Time Resolution

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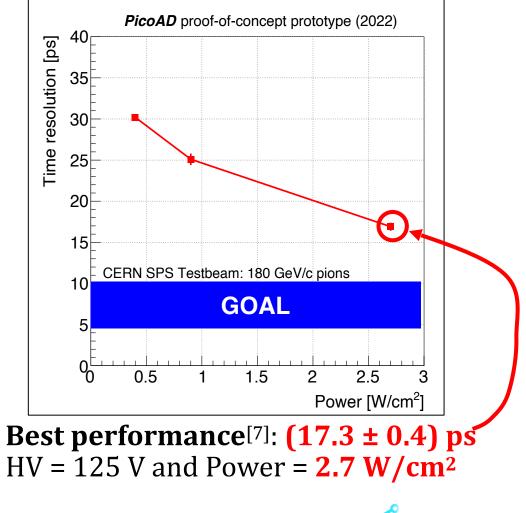
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Similar experimental setup with FE-I4 telescope



99.9% for all the power consumptions

^[7] G. Iacobucci et al, Testbeam results of the Picosecond Avalanche Detector proof-ofconcept prototype, 2022 JINST 17 P10040

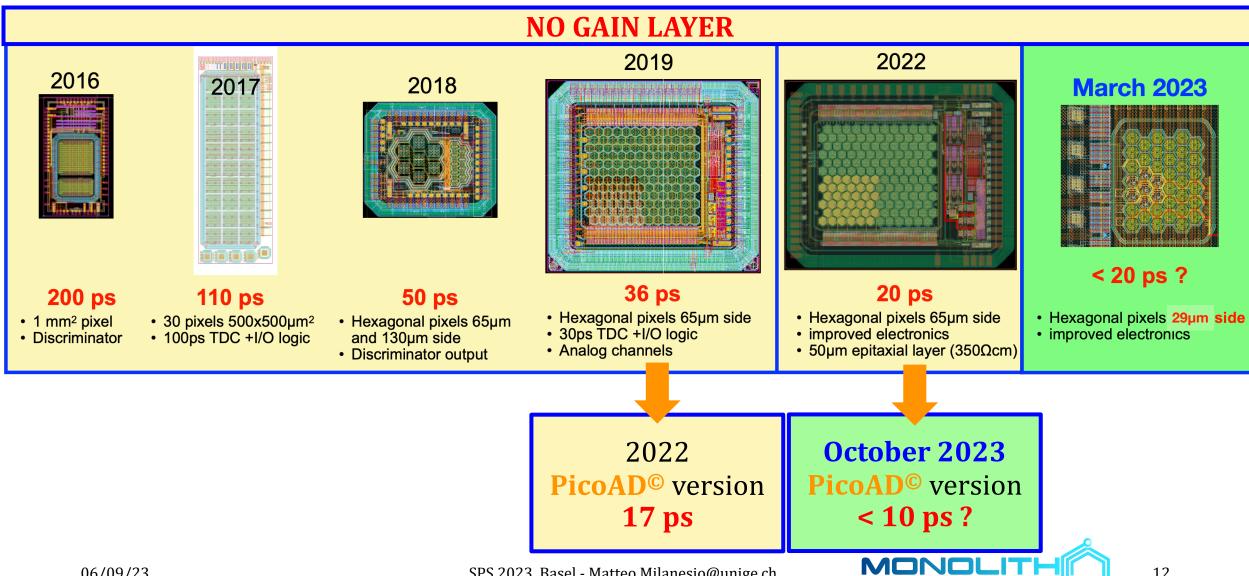


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Future prototypes





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Summary and Outlook



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- Testbeam of 2022 prototype ASIC, without gain layer, provided:
 - Efficiency = 99.8% and $\sigma_t = (20.7 \pm 0.3) \text{ ps}$
- **The PicoAD**[©] **monolithic proof-of-concept prototype works**. The introduction of a deep gain layer improves the performances:
 - Gain ≈ 20 for ⁵⁵Fe X-rays
 - **Efficiency = 99.9 %** including inter-pixel regions
 - Time resolution $\sigma_t = (17.3 \pm 0.4) \text{ ps}$
- Radiation hardness studies started in 2023 together with KEK and IHP
- Development of picosecond TDC^[8] for fully monolithic chip

^[8]R. Cardarelli, L. Paolozzi, P. Valerio and G. Iacobucci, European Patent Application / Filing - UGKP-P-001-EP, Europe Patent EP 18181123.3. 2 July 2018.

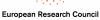






Thanks for your attention





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Giuseppe lacobucci • project P.I. System design



Thanushan Kugathasan Lead chip design Analog electronics



Roberto Cardella Analog electronics Digital electronics



Matteo Milanesio Laboratory test

Data analysis



Antonio Picardi Chip design • Firmware



Jihad Saidi Laboratory test Data analysis

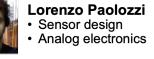


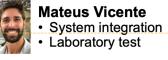
Carlo Alberto Fenoglio Chip design



ALSO AT THIS

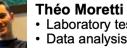
MEETING





Stefano Zambito Laboratory test

Data analysis

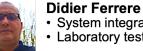


 Laboratory test Data analysis

Chiara Magliocca Laboratory test Data analysis



Luca lodice · Chip design Firmware



System integration Laboratory test



Yannick Favre



Board design





Roberto Cardarelli INFN Rome2 & UNIGE



Holger Rücker IHP Mikroelektronik

Sergio Gonzalez-Sevilla

System integration

Stéphane Débieux

Laboratory test

Board design

RO system

Marzio Nessi **CERN & UNIGE**





Matteo Elviretti **IHP** Mikroelektronik





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Backup

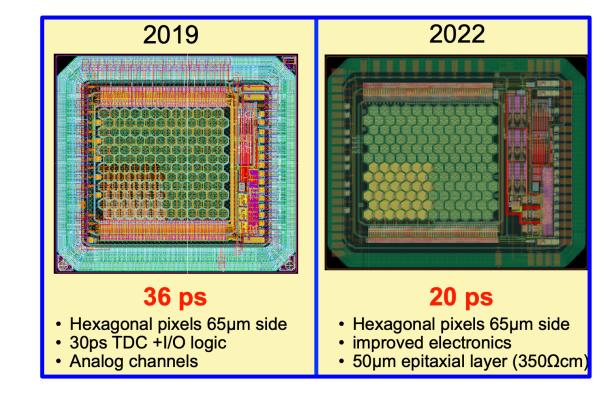




2019->2022: Improvements



- Same matrix configuration as previous, but
 - Substrate: $50 \Omega \text{cm} \rightarrow 350 \Omega \text{cm}$ epilayer, $50 \mu \text{m}$ thick on low-res (1 Ωcm) substrate
 - smaller pixel capacitance
 - depletion 23 $\mu m \rightarrow 50 \; \mu m$
 - much larger voltage plateau
 - can operate sensor with v_{drift} saturated everywhere
 - Preamp and driver voltage decoupled:
 - was limiting optimal amplifier operation
 - cross-talk removed
 - Optimised FE layout, "differential" output, highfrequency cables:
 - better rise time (600 ps \rightarrow 300 ps)





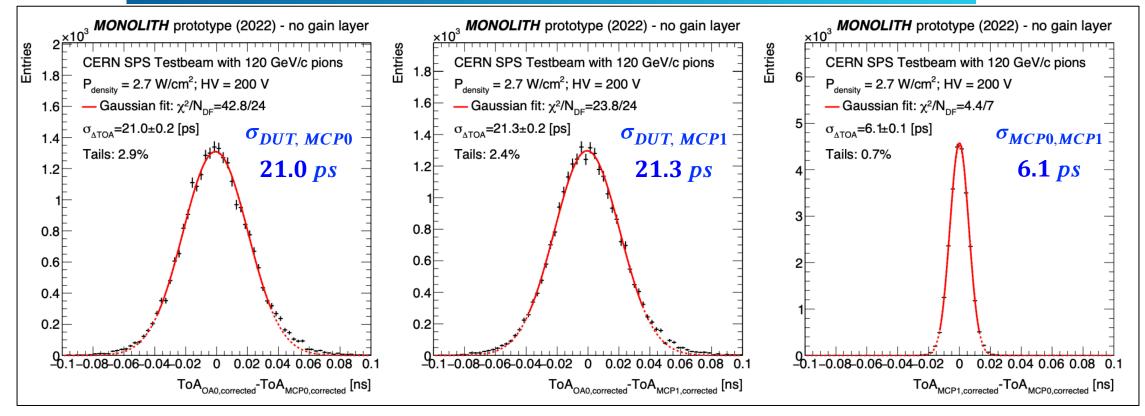


Time Resolution Distributions

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- Very Gaussian distributions after time walk correction
- Simultaneous fit to extract the time resolution of **DUT**, **MCP0**, **MCP1**^[3]:

MCP0: $\sigma_t = (3.6 \pm 1.5) ps$ **MCP1**: $\sigma_t = (5.0 \pm 1.1) ps$

DUT:
$$\sigma_t = (20.7 \pm 0.3) ps$$

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^[3]S. Zambito et al. 20 ps Time Resolution with a Fully-Efficient Monolithic Silicon Pixel Detector without Internal Gain Layer. arXiv:2301.12244v1, January 2023

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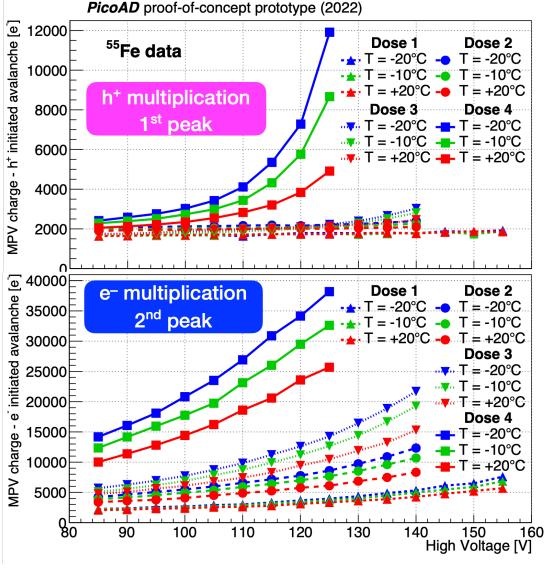
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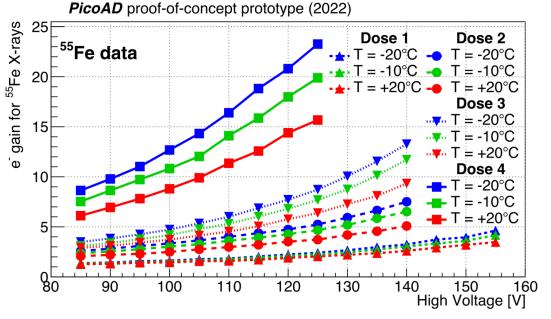
Gain Results







Gain up to ≈ 20 for ⁵⁵Fe X-rays obtained at HV = 125 V and T = -20 °C



- Evidence for gain suppression due to spacecharge effects in the case of ⁵⁵Fe X-rays
- We estimated that ⁵⁵Fe gain of ≈ 20 corresponds to gain 60–70 for a MIP

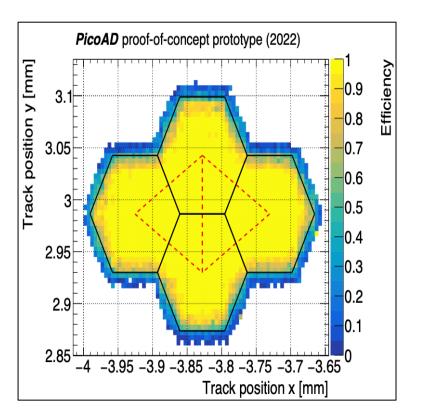


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PicoAD: Efficiency Maps





• The apparent degradation at the edges is due to the finite resolution of the telescope ($\sim 10 \ \mu m$)

- CERN SPS Testbeam: 180 GeV/c pions $V_{tb} = 4 \text{ mV}$; HV = 125 V; Power = 2.7 W/cm² Track position y [mm] Efficiency 3. 0.99 3.05 0.98 0.97 2.95 0.96 2.9 2.85 0.95 -3.95 -3.9 -3.85 -3.8 -3.75 -3.7 -3.65 Track position x [mm]
- Selection of two **triangles**:
 - representative of the whole pixel
 - **unbiased** from the telescope resolution



67<u>4</u> K





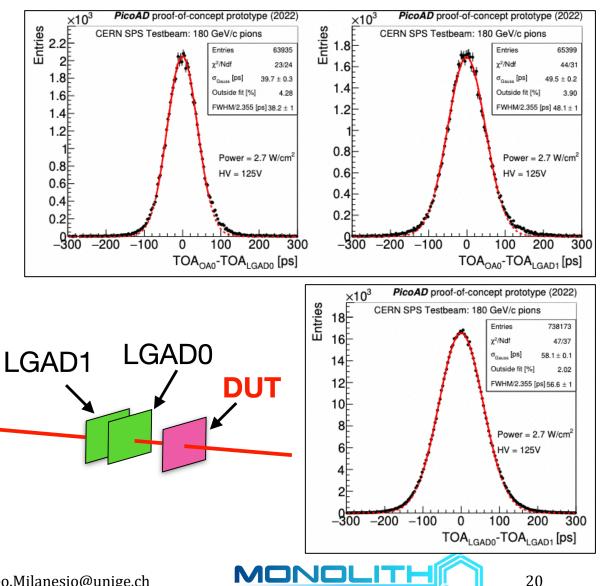
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PicoAD[©]: Time Resolution Distributions

- Time Of Arrival as a time at a **Constant Fraction**
- Distributions after time-walk correction
- The distributions are **gaussian**
 - \sim 2-4 % of the entries are in nongaussian tails
- The three σ_{Gauss} from the fits give the timing resolution of:
 - the DUT
 - the two LGADs

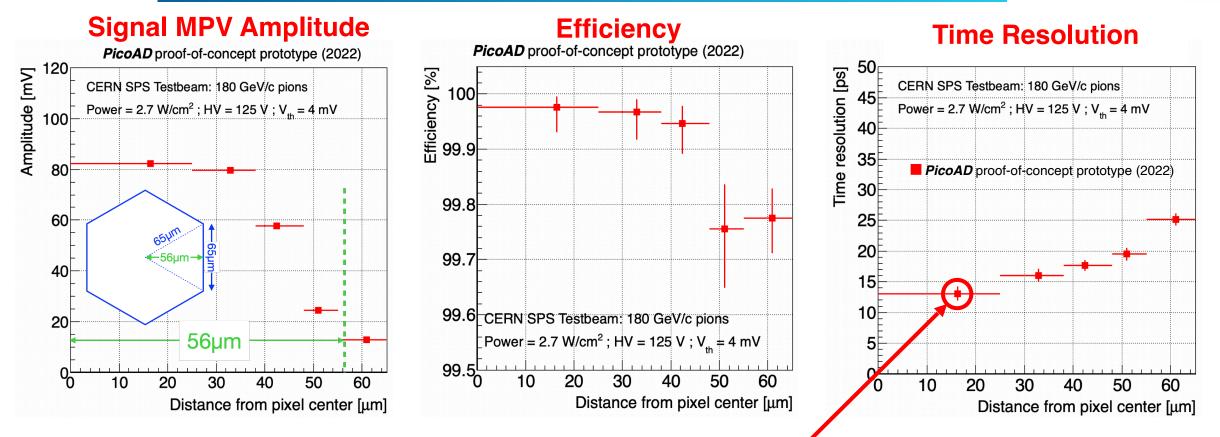






Position Within the Pixel





- Best time resolution: (13.2 ± 0.8) ps within 25 µm from the pixel center
- PicoAD[©] proof-of-concept: small degradation of the performance towards the edge of the pixel

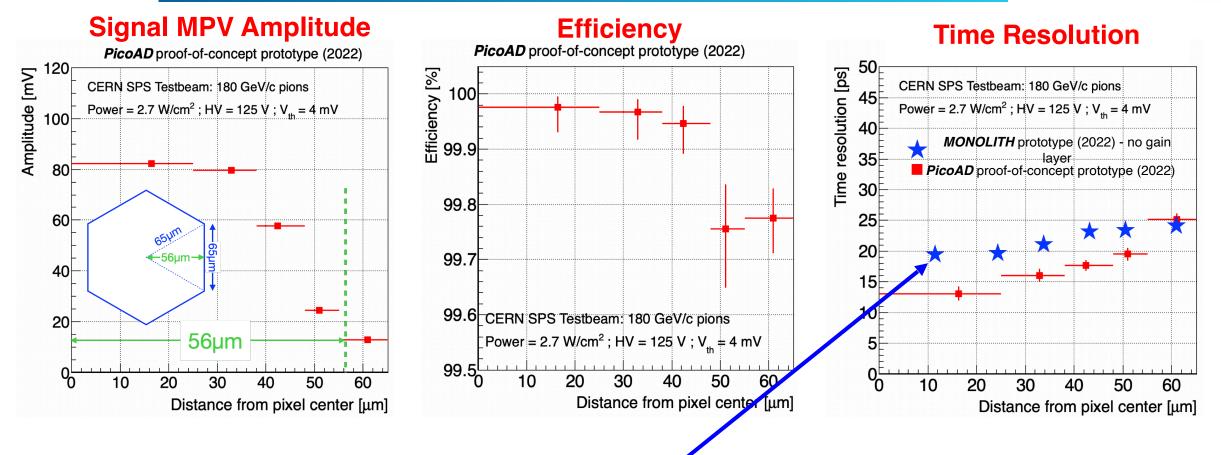




Position Within the Pixel



22



2022 prototype is much **less dependent** on the pixel position





Average Time Jitter [ps]

Radiation Hardness



MONOLITH prototype2 (2022) - no gain layer 60 ⁹⁰Sr data, T = -35 °C HV = 200 V50 $P_{density} = 0.90 \text{ W/cm}^2$ 40 30 20 **Chip Not Irradiated** $\sigma_{t}^{^{90}Sr}$ = (21.0 ± 0.4) ps $\sigma_t =$ 10 dV/dt10¹⁴ **10**¹⁵ **10**¹⁶ Fluence [n_{eq}/cm²]

Excellent news from radiation tolerance studies:

The time jitter with ⁹⁰Sr increases from 21ps (unirradiated) to 46ps (at $10^{16} n_{eq}/cm^2$) at HV = 200V and 0.9 W/cm²

Enough parameters (i_{fbk}, V_{CCA}, HV) for smooth and effective operation even at $10^{16} n_{eq}/cm^2$





Benefits of Using Hexagonal Pixels





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- Three possible regular shapes to use:
 - equilateral triangles
 - squares
 - regular hexagons
- Hexagons have the highest angles (120°) -> electric fields in the corners are better under control
- Moreover, the same amount of pixels can fits in less space than squares

